



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Yoshihiro SASAKI, et al.

Title: PROBE TESTING METHOD AND APPARATUS FOR DETERMINING ACCEPTABLE/DEFECTIVE END SHAPE OF CONTACT PROBE THROUGH IMAGE ANALYSIS

Appl. No.: 10/644,071

Filing Date: 08/20/2003

Examiner: Unknown

Art Unit: 2857

TRANSMITTAL OF FORMAL DRAWINGS

Commissioner for Patents
PO Box 1450
Alexandria, Virginia 22313-1450

ATTENTION: DRAWING REVIEW BRANCH

Sir:

Transmitted herewith are the formal drawings (11 sheets, Figures 1-4, 5a, 5b, 6, 7a, 7b, 7c, 7d, 7e, 7f, 7g, 8a, 8b, 9a, 9b, 9c, 10-13) for the above-identified application. The Official Draftsperson is respectfully requested to approve these drawings for entry into the application.

Respectfully submitted,

Date: December 9, 2003

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